


<b>Search Notes</b>  	<b>Application/Control No.</b>  10582694	<b>Applicant(s)/Patent Under Reexamination</b>  BAYER ET AL.
	<b>Examiner</b>  Aaron R Eastman	<b>Art Unit</b>  3745

SEARCHED			
Class	Subclass	Date	Examiner
416	215, 214A, 214R, 220R, 221, 248	03/17/2011	ARE
29	889.21	03/18/2011	ARE
416	219R, 220A, 219A, 204A	03/18/2011	ARE
Update	Above	10/18/2011	ARE

SEARCH NOTES		
Search Notes	Date	Examiner
Ninh Nguyen	03/17/2011	ARE
Richard Edgar	03/18/2011	ARE
Nathan Wiehe	03/18/2011	ARE
Nathan Wiehe	10/06/2011	ARE
Nathan Wiehe	10/18/2011	ARE

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
All	Above	10/18/2011	ARE

--	--